

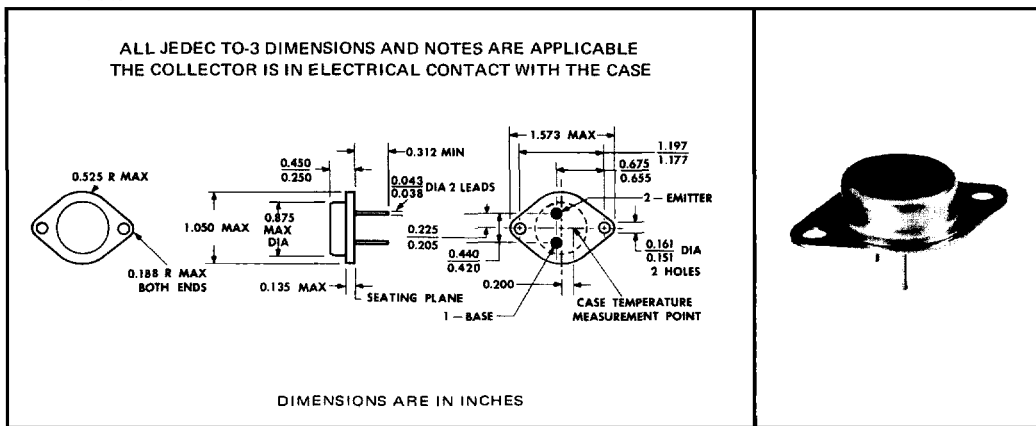
TYPES 2N5881, 2N5882 N-P-N SINGLE-DIFFUSED SILICON POWER TRANSISTORS

FOR POWER-AMPLIFIER AND HIGH-SPEED-SWITCHING APPLICATIONS
DESIGNED FOR COMPLEMENTARY USE WITH 2N5879, 2N5880

- 160 Watts at 25°C Case Temperature
- 15-A Rated Continuous Collector Current
- Min f_T of 4 MHz at 10 V, 1 A
- 90-mJ Reverse Energy Rating

TYPES 2N5881, 2N5882
BULLETIN NO. DL-S-711625, DECEMBER 1971

***mechanical data**



absolute maximum ratings at 25°C case temperature (unless otherwise noted)

| | 2N5881 | 2N5882 |
|--|-------------------------|--------|
| Collector-Base Voltage | 60 V* | 80 V* |
| Collector-Emitter Voltage (See Note 1) | 60 V* | 80 V* |
| Emitter-Base Voltage | 5 V* | 5 V* |
| Continuous Collector Current | ← { 15 A } / { 12 A } → | |
| Peak Collector Current (See Note 2) | ← 20 A → | |
| Continuous Base Current | ← 4 A* → | |
| Safe Operating Area at (or below) 25°C Case Temperature | See Figure 1 | |
| Continuous Device Dissipation at (or below) 25°C Case Temperature (See Note 3) | ← 160 W* → | |
| Continuous Device Dissipation at (or below) 25°C Free-Air Temperature (See Note 4) | ← 5 W → | |
| Unclamped Inductive Load Energy (See Note 5) | ← 90 mJ → | |
| Operating Collector Junction Temperature Range | ← -65°C to 200°C* → | |
| Storage Temperature Range | ← -65°C to 200°C* → | |
| Terminal Temperature 1/16 Inch from Case for 10 Seconds | ← 250°C* → | |

- NOTES: 1. These values apply when the base-emitter diode is open-circuited.
 2. This value applies for $t_{w} \leq 1$ ms, duty cycle $\leq 10\%$.
 3. Derate linearly to 200°C case temperature at the rate of 0.915 W/°C.
 4. Derate linearly to 200°C free-air temperature at the rate of 28.6 mW/°C.
 5. This rating is based on the capability of the transistors to operate safely in the unclamped inductive load circuit of Section 3.2 of the forthcoming JEDEC publication *Suggested Standards on Power Transistors*. † L = 20 mH, $R_{BB1} = 20 \Omega$, $R_{BB2} = 100 \Omega$, $V_{BB1} = 10$ V, $V_{BB2} = 0$ V, $R_L = 0.1 \Omega$, $V_{CC} = 10$ V, $I_{CM} = 3$ A. Energy $\approx I_C^2 L/2$.

*JEDEC registered data. This data sheet contains all applicable registered data in effect at the time of publication.

†Texas Instruments guarantees this value in addition to the JEDEC registered value which is also shown.

‡This circuit appears on page 5-1 of this data book.

TYPES 2N5881, 2N5882

N-P-N SINGLE-DIFFUSED SILICON POWER TRANSISTORS

*electrical characteristics at 25°C case temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | 2N5881 | | 2N5882 | | UNIT |
|--|---|--------|-----|--------|-----|------|
| | | MIN | MAX | MIN | MAX | |
| $V_{(BR)CEO}$ Collector-Emitter Breakdown Voltage | $I_C = 0.2 \text{ A}$, $I_B = 0$, See Note 6 | 60 | | 80 | | V |
| I_{CEO} Collector Cutoff Current | $V_{CE} = 30 \text{ V}$, $I_B = 0$ $V_{CE} = 40 \text{ V}$, $I_B = 0$ | 1 | | 1 | | mA |
| I_{CEV} Collector Cutoff Current | $V_{CE} = 60 \text{ V}$, $V_{BE} = -1.5 \text{ V}$ | 0.5 | | | | |
| | $V_{CE} = 80 \text{ V}$, $V_{BE} = -1.5 \text{ V}$ | | | 0.5 | | |
| | $V_{CE} = 60 \text{ V}$, $V_{BE} = -1.5 \text{ V}$, $T_C = 150^\circ\text{C}$ | 5 | | | | |
| | $V_{CE} = 80 \text{ V}$, $V_{BE} = -1.5 \text{ V}$, $T_C = 150^\circ\text{C}$ | | | 5 | | |
| I_{CBO} Collector Cutoff Current | $V_{CB} = 60 \text{ V}$, $I_E = 0$ | 0.5 | | | | mA |
| | $V_{CB} = 80 \text{ V}$, $I_E = 0$ | | | 0.5 | | |
| I_{EBO} Emitter Cutoff Current | $V_{EB} = 5 \text{ V}$, $I_C = 0$ | 1 | | 1 | | mA |
| | $V_{CE} = 4 \text{ V}$, $I_C = 2 \text{ A}$ | 35 | | 35 | | |
| h_{FE} Static Forward Current Transfer Ratio | $V_{CE} = 4 \text{ V}$, $I_C = 6 \text{ A}$ | 20 | 100 | 20 | 100 | |
| | $V_{CE} = 4 \text{ V}$, $I_C = 12 \text{ A}$ | 5 | | 5 | | |
| | See Notes 6 and 7 | | | | | |
| V_{BE} Base-Emitter Voltage | $I_B = 0.7 \text{ A}$, $I_C = 7 \text{ A}$ | 1.6 | | 1.6 | | V |
| | $V_{CE} = 4 \text{ V}$, $I_C = 12 \text{ A}$ | 2.5 | | 2.5 | | |
| $V_{CE(sat)}$ Collector-Emitter Saturation Voltage | $I_B = 0.7 \text{ A}$, $I_C = 7 \text{ A}$ | 1 | | 1 | | V |
| | $I_B = 2.4 \text{ A}$, $I_C = 12 \text{ A}$ | 4 | | 4 | | |
| h_{fe} Small-Signal Common-Emitter Forward Current Transfer Ratio | $V_{CE} = 4 \text{ V}$, $I_C = 2 \text{ A}$, $f = 1 \text{ kHz}$ | 20 | | 20 | | |
| h_{fe1} Small-Signal Common-Emitter Forward Current Transfer Ratio | $V_{CE} = 10 \text{ V}$, $I_C = 1 \text{ A}$, $f = 1 \text{ MHz}$ | 4 | | 4 | | |
| C_{obo} Common-Base Open-Circuit Output Capacitance | $V_{CB} = 10 \text{ V}$, $I_E = 0$, $f = 1 \text{ MHz}$ | 400 | | 400 | | pF |

NOTES: 6. These parameters must be measured using pulse techniques. $t_w \approx 300 \mu\text{s}$, duty cycle $\leq 2\%$.

7. These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts and located within 0.125 inch from the device body.

*switching characteristics at 25°C case temperature

| PARAMETER | TEST CONDITIONS† | MIN | MAX | UNIT |
|--------------------|--|-----|-----|---------------|
| t_r Rise Time | $I_C = 6 \text{ A}$, $I_B(1) = 0.6 \text{ A}$, $I_B(2) = -0.6 \text{ A}$, $V_{BE(off)} = -5 \text{ V}$, $R_L = 5 \Omega$, See Note 8 | 0.7 | | μs |
| t_s Storage Time | | 1 | | |
| t_f Fall Time | | 0.8 | | |

† Voltage and current values shown are nominal; exact values vary slightly with transistor parameters.

*JEDEC registered data.

NOTE 8: These characteristics are measured in the circuit of clause 3.3.13.2 of the forthcoming JEDEC publication *Suggested Standards on Power Transistor*. $V_{BB1} = 23 \text{ V}$, $V_{BB2} = 5 \text{ V}$, $V_{CC} = 30 \text{ V}$, $V_{on} = 20.5 \text{ V}$, $R_{BB1} = 16 \Omega$, $R_{BB2} = 10 \Omega$.

‡ This circuit appears on page 5-1 of this data book.

MAXIMUM SAFE OPERATING AREA

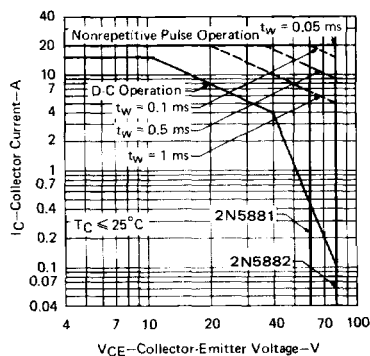


FIGURE 1

THERMAL CHARACTERISTICS

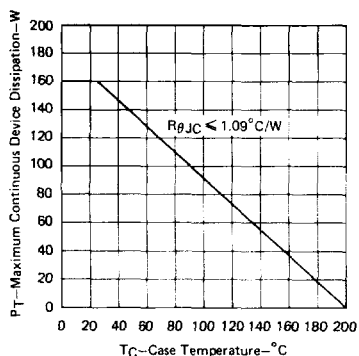


FIGURE 2